



#### 0.75W POWER pHEMT

Package Style: Bare Die

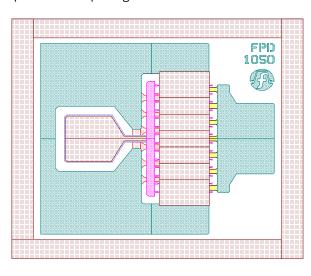




#### **Product Description**

The FPD1050 is an AlGaAs/InGaAs pseudomorphic High Electron Mobility Transistor (pHEMT), featuring a  $0.25\,\mu\text{mx}\,1050\,\mu\text{m}$  Schottky barrier gate, defined by high-resolution stepper-based photolithography. The double recessed gate structure minimizes parasitics to optimize performance. The epitaxial structure and processing have been optimized for reliable high-power applications. The FPD1050 is also available in the low-cost plastic SOT89 package.





#### **Features**

- 28.5dBm Linear Output Power at 12GHz
- 11dB Power Gain at 12GHz
- 14dB Max Stable Gain at 12GHz
- 41dBm O<sub>IP3</sub>
- 45% Power-Added Efficiency

#### **Applications**

- Narrowband and Broadband High-Performance Amplifiers
- SATCOM Uplink Transmitters
- PCS/Cellular Low-Voltage High-Efficiency Output Amplifiers
- Medium-Haul Digital Radio Transmitters

Baramatar	Specification		Hois	Condition	
Parameter	Min.	Тур.	Max.	Unit	Condition
P <sub>1dB</sub> Gain Compression	27.5	28.5		dBm	V <sub>DS</sub> =8V, I <sub>DS</sub> =50% I <sub>DSS</sub>
S21/S12 (MSG)		14.0		dB	V <sub>DS</sub> =8V, I <sub>DS</sub> =50% I <sub>DSS</sub>
Power Gain at P <sub>1dB</sub> (G <sub>1dB</sub> )	10.0	11.0		dB	V <sub>DS</sub> =8V, I <sub>DS</sub> =50% I <sub>DSS</sub>
PAE		45		%	V <sub>DS</sub> =8V, I <sub>DS</sub> =50% I <sub>DSS</sub> , P <sub>OUT</sub> =P <sub>1dB</sub>
OIP <sub>3</sub>		39		dBm	V <sub>DS</sub> =8V, I <sub>DS</sub> =50% I <sub>DSS</sub>
		41		dBm	Matched for optimal power, tuned for best IP <sub>3</sub>
Saturated Drain-Source Current (IDSS)	260	325	385	mA	V <sub>DS</sub> =1.3V, V <sub>GS</sub> =0V
Maximum Drain-Source Current (IMAX)		520		mA	V <sub>DS</sub> =1.3V, V <sub>GS</sub> ≈+1V
Transconductance (GM)		280		ms	V <sub>DS</sub> =1.3V, V <sub>GS</sub> =0V
Gate-Source Leakage Current (IGSO)		15		μΑ	V <sub>GS</sub> =-5V
Pinch-Off Voltage (V <sub>P</sub> )		1.0		V	V <sub>DS</sub> =1.3V, I <sub>DS</sub> =1mA
Gate-Source Breakdown Voltage (V <sub>BDGS</sub> )	12.0	14.0		V	I <sub>GS</sub> =3 mA
Gate-Drain Breakdown Voltage (V <sub>BDGD</sub> )	14.5	16.0		V	I <sub>GD</sub> =3 mA
Thermal Resistivity (θJC) *		45		°C/W	V <sub>DS</sub> >6V

<sup>\*</sup>Note:  $T_{AMBIENT}$  = 22 °C, RF specifications measured at f = 12 GHz using CW signal.



#### Absolute Maximum Ratings<sup>1</sup>

Parameter	Rating	Unit
Drain-Source Voltage (V <sub>DS</sub> ) (-3V <v<sub>GS&lt;-0.5V)<sup>2</sup></v<sub>	10	V
Gate-Source Voltage (V <sub>GS</sub> ) (0V < V <sub>DS</sub> < +8V)	-3	V
Drain-Source Current (I <sub>DS</sub> ) (For V <sub>DS</sub> <2V)	I <sub>DSS</sub>	
Gate Current (I <sub>G</sub> ) (Forward or reverse)	10	mA
RF Input Power (P <sub>IN</sub> ) (Under any acceptable bias state)	23	dBm
Channel Operating Temperature (T <sub>CH</sub> ) (Under any acceptable bias state)	175	°C
Storage Temperature (T <sub>STG</sub> ) (Non-Operating Storage)	-65 to 150	°C
Total Power Dissipation (P <sub>TOT</sub> ) <sup>3, 4, 5</sup>	3.4	W
Simultaneous Combination of Limits <sup>6</sup> (2 or more max. limits)	80	%



<sup>&</sup>lt;sup>1</sup>T<sub>AMBIENT</sub> = 22 °C unless otherwise noted; exceeding any one of these absolute maximum ratings may cause permanent damage to the device.

# **A**

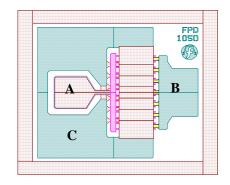
Caution! ESD sensitive device.

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability. Specified typical performance or functional operation of the device under Absolute Maximum Rating conditions is not implied.

RoHS status based on EUDirective 2002/95/EC (at time of this document revision).

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## Pad Layout



Pad	Description	Pin Coordinates (μm)
Α	Gate pad.	130, 220
В	Drain pad.	380, 220
С	Source pad.	

Note: Coordinates are referenced from the bottom left hand corner of the die to the center of the bond pad opening.

Die Size (μm)	Die Thickness (μm)	Min. Bond Pad Opening (μmxμm)
470x440	75	67x77

 $<sup>^2</sup>$  Operating at absolute maximum  $\rm V_D$  continuously is not recommended. If operation at 10V is considered then  $\rm I_{DS}$  must be reduced in order to keep the part within its thermal power dissipation limits. Therefore  $\rm V_{GS}$  is restricted to <-0.5V.

 $<sup>^3\</sup>text{Total}$  Power Dissipation to be de-rated as follows above 22 °C:  $P_{\text{TOT}} = 3.4 - (0.022\text{W}/\,^\circ\text{C})xT_{\text{HS}}$ , where  $T_{\text{HS}} =$  heatsink or ambient temperature above 22 °C. Example: For a 85 °C carrier temperature:  $P_{\text{TOT}} = 3.4 - (0.022\text{x}(85-22)) = 2.01\text{W}$ 

 $<sup>^{4}\</sup>text{Total Power Dissipation }(P_{\text{TOT}})$  defined as  $(P_{\text{DC}} + P_{\text{IN}}) - P_{\text{OUT}}$ , where  $P_{\text{DC}}$ : DC Bias Power,  $P_{\text{IN}}$ : RF Input Power,  $P_{\text{OUT}}$ : RF Output Power.

<sup>&</sup>lt;sup>5</sup>Users should avoid exceeding 80% of 2 or more Limits simultaneously.

<sup>&</sup>lt;sup>6</sup>Thermal Resistivity specification assumes a Au/Sn eutectic die attach onto an Auplated copper heatsink or rib.



#### **Preferred Assembly Instructions**

GaAs devices are fragile and should be handled with great care. Specially designed collets should be used where possible.

The back of the die is metallized and the recommended mounting method is by the use of conductive epoxy. Epoxy should be applied to the attachment surface uniformly and sparingly to avoid encroachment of epoxy on to the top face of the die and ideally should not exceed half the chip height. For automated dispense Ablestick LMISR4 is recommended. For manual dispense Ablestick 84-1 LMI or 84-1 LMIT are recommended. These should be cured at a temperature of 150 °C for 1 hour in an oven especially set aside for epoxy curing only. If possible, the curing oven should be flushed with dry nitrogen. The gold-tin (80% Au 20% Sn) eutectic die attach has a melting point of approximately 280 °C but the absolute temperature being used depends on the leadframe material used and the particular application. The maximum time should be kept to a minimum.

This part has gold (Au) bond pads requiring the use of gold (99.99% pure) bondwire. It is recommended that 25.4 mm diameter gold wire be used. Recommended lead bond technique is thermocompression wedge bonding with 0.001" (25 µm) diameter wire. Bond force, time stage temperature, and ultrasonics are all critical parameters and the settings are dependant on the setup and application being used. Ultrasonic or thermosonic bonding is not recommended.

Bonds should be made from the die first and then to the mounting substrate or package. The physical length of the bondwires should be minimized especially when making RF or ground connections.

#### **Handling Precautions**



To avoid damage to the devices, care should be exercised during handling. Proper Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing.

#### **ESD/MSL Rating**

These devices should be treated as Class 0 (0V to 250V) using the human body model as defined in JEDEC Standard No. 22-A114. Further information on ESD control measures can be found in MIL-STD-1686 and MIL-HDBK-263.

### **Application Notes and Design Data**

Application Notes and design data including S-parameters and device model are available on request and from www.rfmd.com.

## Reliability

An MTTF of in excess of 4.2 million hours at a channel temperature of 150 °C is achieved for the process used to manufacture this device.

#### **Disclaimers**

This product is not designed for use in any space-based or life-sustaining/supporting equipment.

### **Ordering Information**

<b>Delivery Quantity</b>	Ordering Code	
Standard Order Quantity (waffle-pack)	FPD1050-000	
Small Quantity (25)	FPD1050-000SQ	
Small Quantity (3)	FPD1050-000S3	

# FPD1050

